

Material budget study for a CMOS VTX concept

Damien Grandjean Marc Winter

- A reminder of the Vertex Detector constraints
- Material budget assumed for the simulation
- Constraints from beamstrahlung background
- The CMOS vertex detector concept
- Impact of fast readout on material budget
- Simulation of the impact parameter resolution
- Conclusion

Reminder : Major constraints

■ Impact parameter resolution :

$$\sigma_{\text{I.P.}} = a \text{ } \mu\text{m} \oplus b \text{ } \mu\text{m} / p \cdot \sin^{3/2}\theta \text{ with } a < 5 \text{ and } b < 10$$

- Very high granularity
- Very thin (minimise multiple scattering)
- As close as possible to the I.P.

■ Machine environment : Beamstrahlung

- Aggressive fast readout $\Rightarrow$ material budget ?
 - Impact on b parameter ? (BRAHMS simulation)
- Radiation Hardness

Material budget use in the simulation

- Beam pipe $\sim 500 \mu\text{m}$ thick (TESLA TDR)

This corresponds to $0.14\% X_0$

- Sensor thickness:

- Aim for $\leq 50 \mu\text{m}$ Si (use in this simulation)

- Back thinning tests of Mimosa-5 are running

- LBNL : Mimosa-5 chips work after thinning to $50 \mu\text{m}$ (industrial process)

- IReS / Tracit : similar thinning of Mimosa-5 ($70 \mu\text{m}$ today $40 \mu\text{m}$)

- SUCIMA : study for e^- of few keV detection : thinning Mimosa-5 to $15 \mu\text{m}$ (no standard process) not yet adapted for m.i.p. detection.

- $25 \mu\text{m}$ thick sensors achievable ?

- Detector support structures :

- Not detailed in this study.

- Assumption: simple ladder $\sim 50 \mu\text{m}$ C thick

Cooling and operation temperature

■ Cooling requirements:

- Detectors are best performing near 0° C or below
 - Less dark current namely after irradiation
 - Less shot noise
- Room temperature operation is however not excluded
 - Opto processes and improved structures help to controll dark current
 - First promising results were archived with Mi9, Mi11, ongoing study

■ A Light cooling system is studied by DESY, Univ. HH

- Cooling agent R314a
- Compressed gas expands in Al pipe (600 μm diameter, 50 μm thick) place under readout electronic part along the ladder : $1.2 \times 10^{-4} X_0$ in average
- -12 °C achieved
- Long term temperature stability is still to be improved

**A light cooling system is not yet included in the simulation.
The cryostat is use in this study**

Constraints from beamstrahlung background

Base line of the detector concept TESLA TDR

- Radius of the inner layer : 15 mm
- readout speed 50 μ s
- $B = 4T$

Question : Is this consistent with beamstrahlung ?

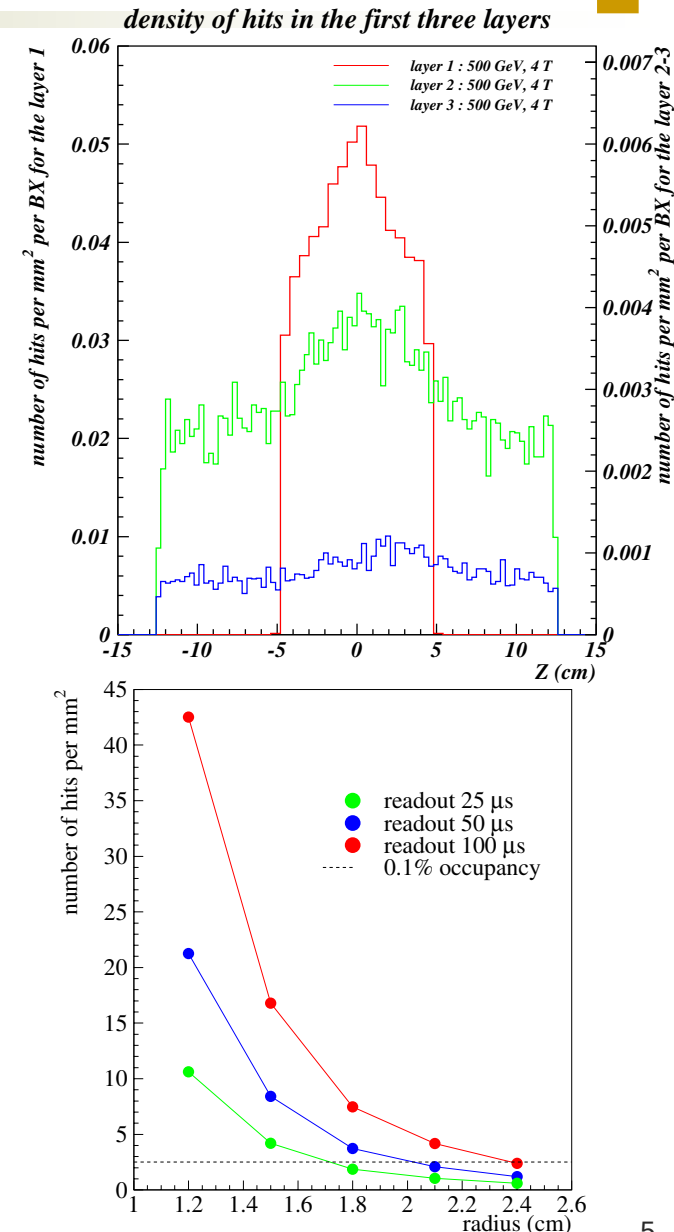
Monte Carlo on beamstrahlung pairs (100 BX) :

- 5 hits/mm²/BX at 90° in layer L0

Occupancy (20 μ m pitch, 50 μ s readout):

- Cluster multi. (x 5- 10)
- Safety factor (X 3)
- ⇒ **Occupancy 5-10 %**

Conclusion: < 25 μ s readout time is required in L0
and < 50 μ s readout time is required in L1



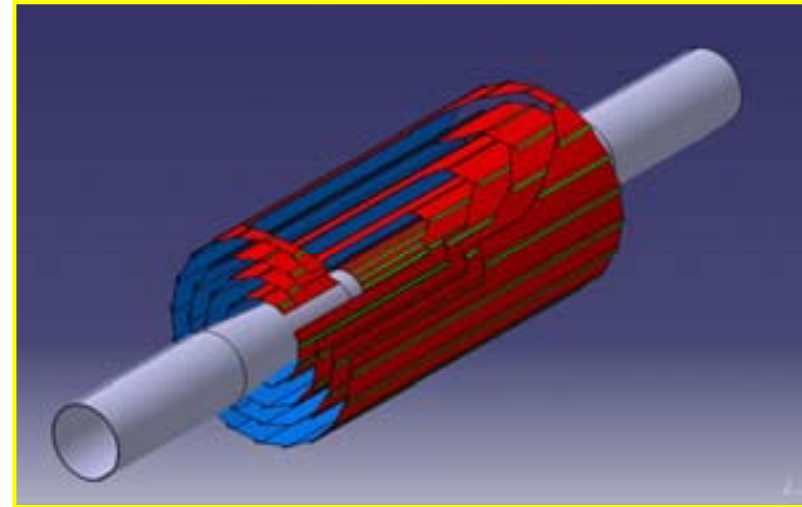
The CMOS Vertex Detector Concept

■ Based on TESLA TDR geom.

- 5 concentric layers
- Radii ranging from 15 to 60 mm
- Polar angle coverage $|\cos\theta| \sim 0.9 - 0.95$

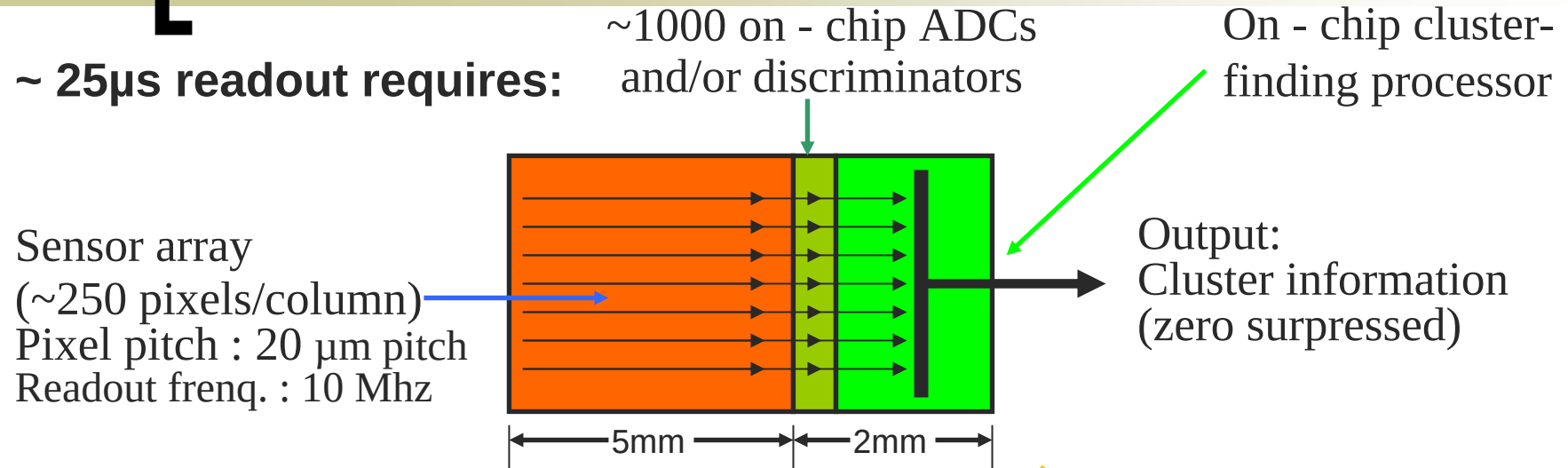
■ But quite different

- More aggressive readout speed
 - 25 μs for L0
 - 50 μs for L1
 - massive // processing
 - < 200 μs for L2, L3 and L4
 - ≥ 5 memory cells
- Less pixels : ~ 300 M
 - varied pixel size depending on layer (20 to 40 μm)
- Low power dissipation
 - $P_{\text{mean}} < 3 - 30$ W
(duty cycle = 1/200 - 1/20)



Layer	Pitch	$t_{\text{r.o.}}$	N_{lad}	N_{pix}	$P_{\text{inst}}^{\text{diss}}$	$P_{\text{mean}}^{\text{dis}}$
L0	20 μm	25 μs	20	25M	< 100 W	< 5 W
L1	25 μm	50 μs	26	65M	< 130 W	< 7 W
L2	30 μm	<200 μs	24	75M	< 100 W	< 5 W
L3	35 μm	<200 μs	32	70M	< 110 W	< 6 W
L4	40 μm	<200 μs	40	70M	< 125 W	< 6 W
total			142	305M	< 565 W	<29 W

Impact of fast readout on material budget



On chip logic area can't be made sensitive

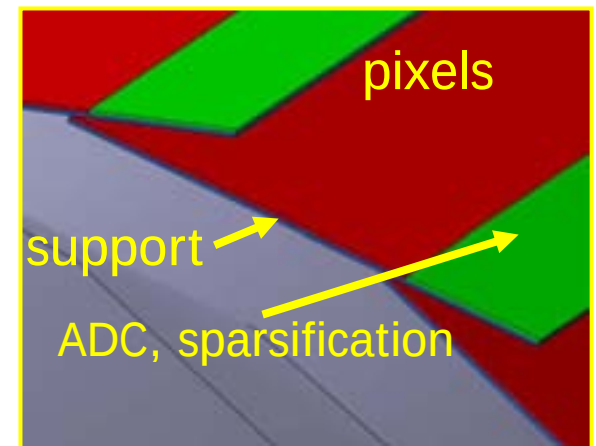
- small pixel size
- can't use pmos trans. in active part

Need electronic band part

- ADC, sparsification, signal extraction
- ⇒ Increases material budget (except small polar angles)

Question:

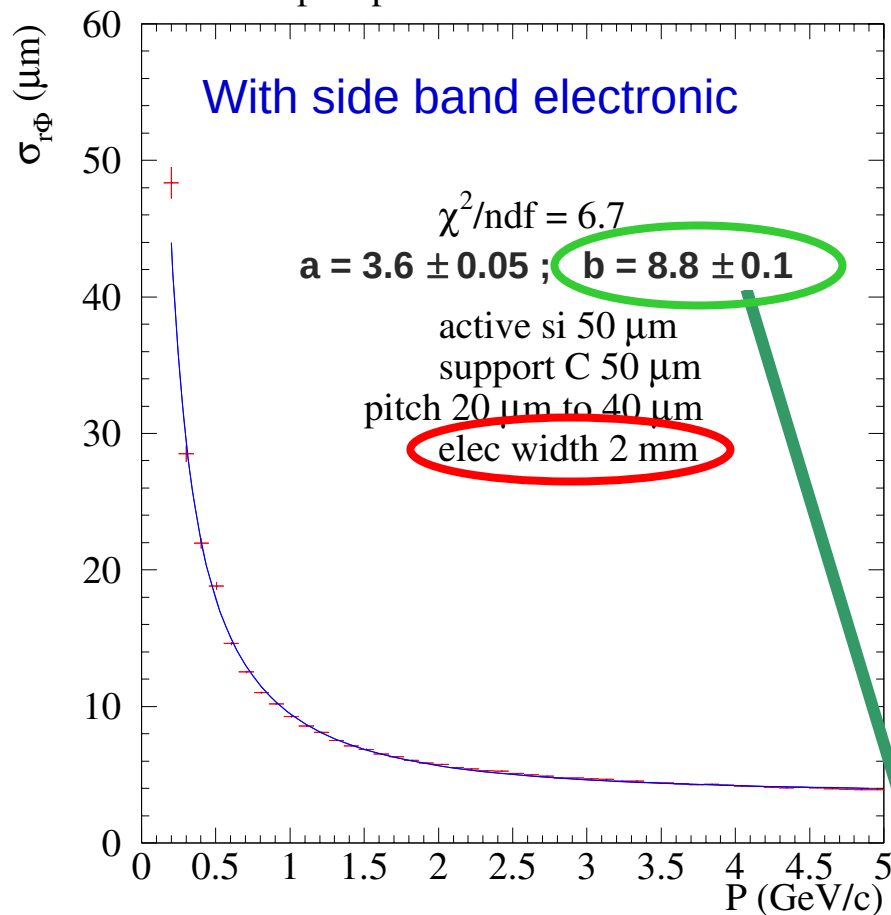
What is the impact on the b parameter ?



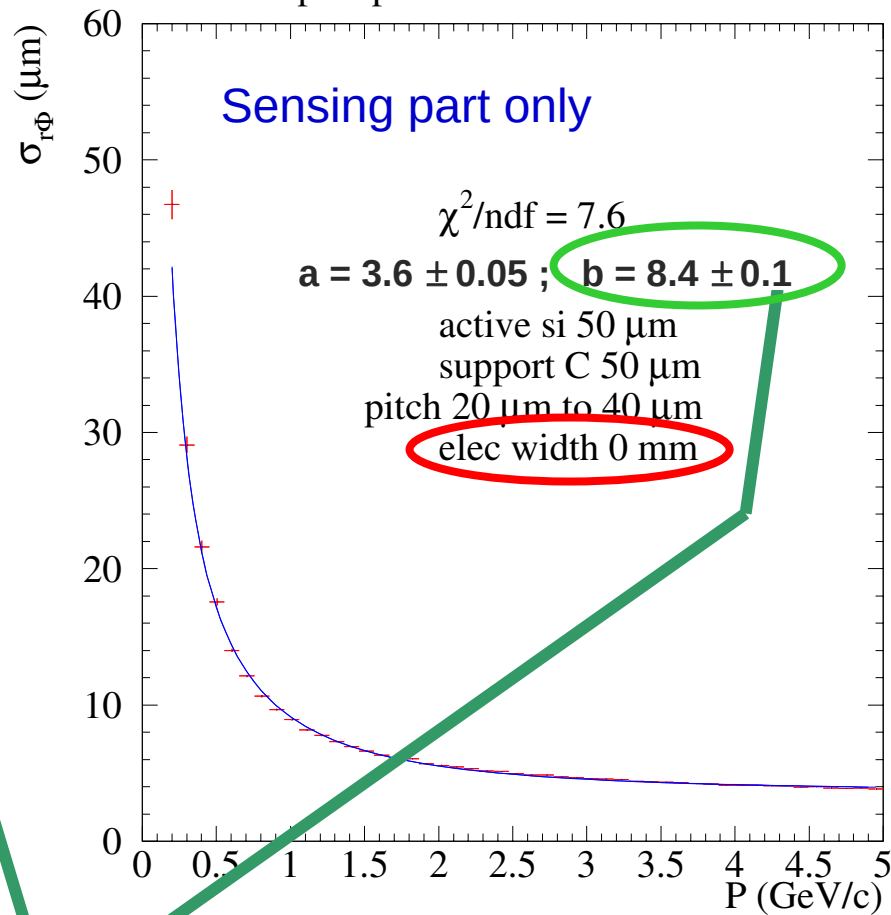
Simulation Results : influence of the side band

CMOS vertex detector geometry

impact parameter resolution



impact parameter resolution



The b parameter grows by a few % only

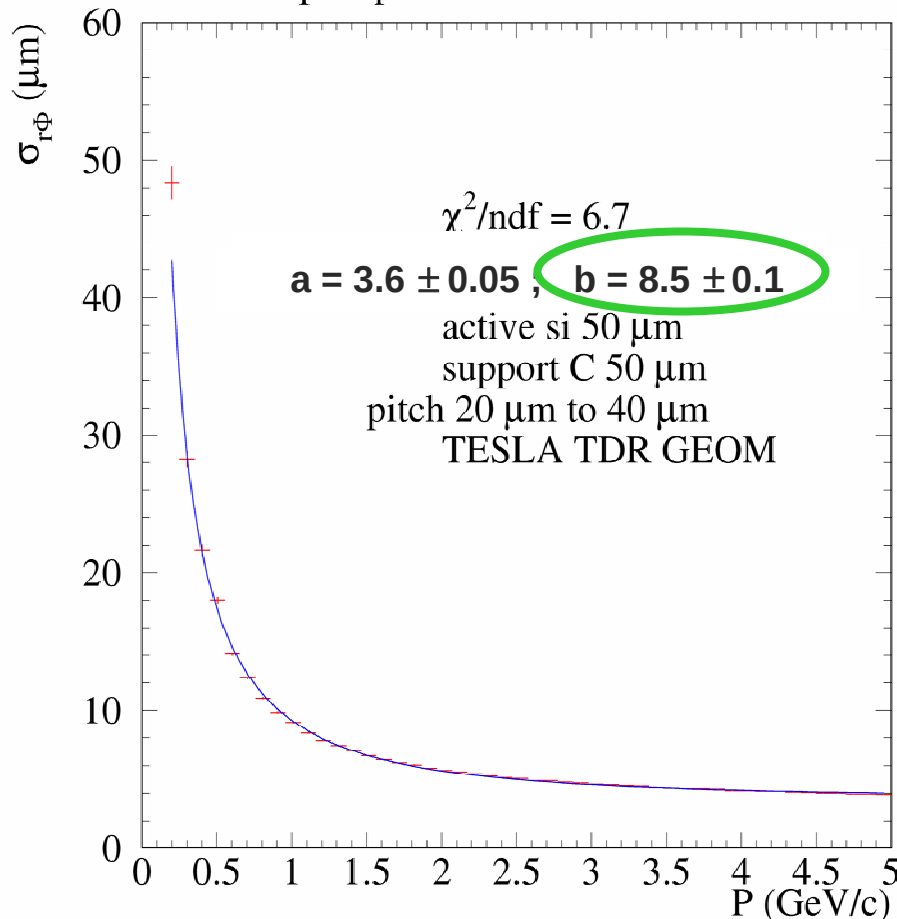
Simulation Results : influence of the ladder number

TESLA TDR geometry :

L0 : 8 ladders width 15 mm

⇒ readout speed : 50 μ s

impact parameter resolution



CMOS geometry :

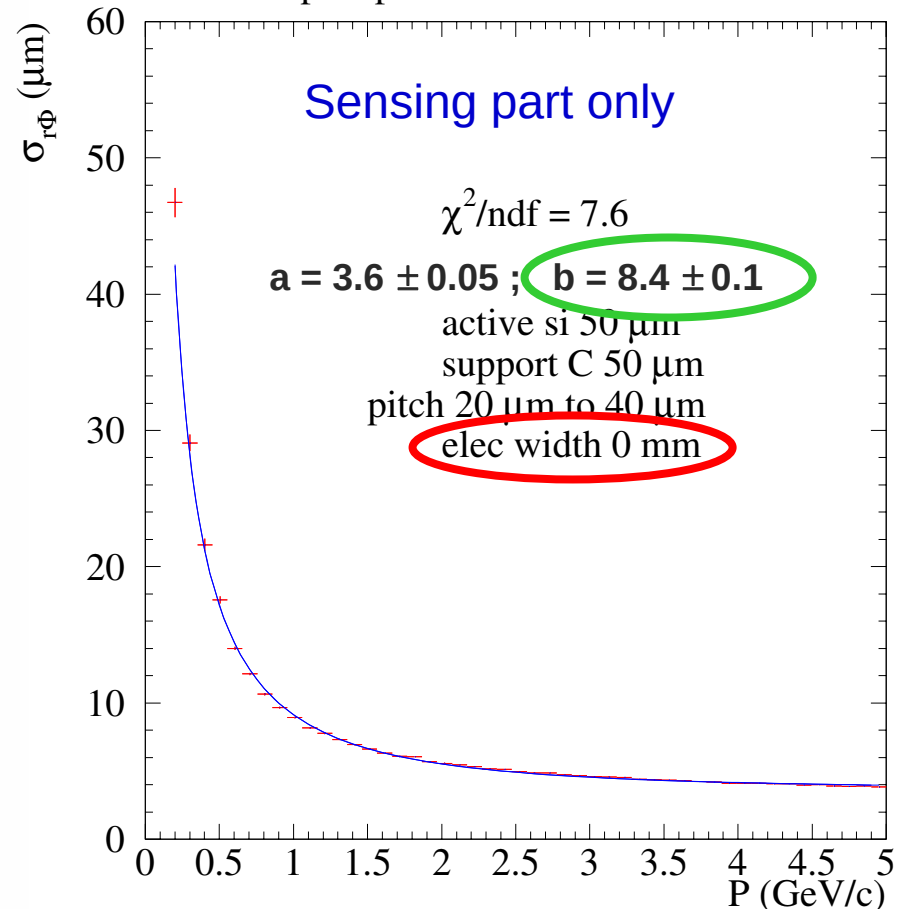
L0 : 20 ladders width 5 mm

⇒ readout speed : 25 μ s

L1 : 13 ladders width 13 mm

⇒ readout speed : 50 μ s

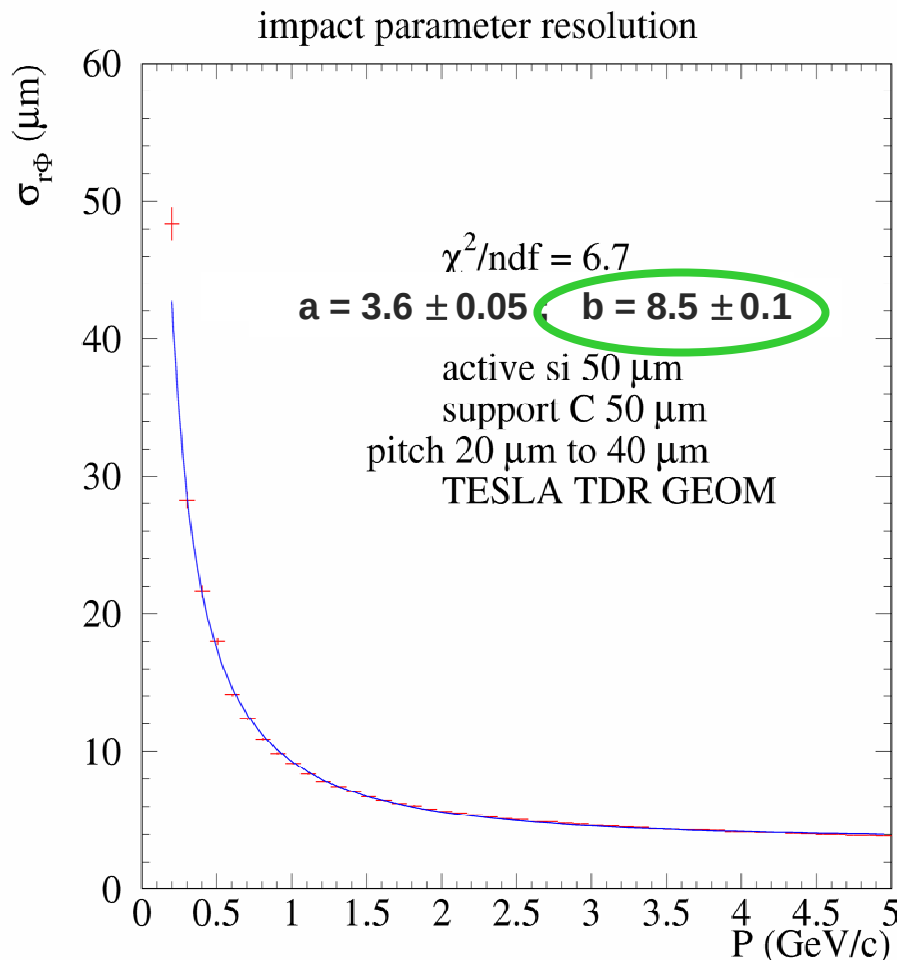
impact parameter resolution



Simulation Results : influence of the radius of L0

TDR TESLA geometry
Radius L0 = 1.5 cm

TDR TESLA geometry
Radius L0 = 1.8 cm



$$a = 3.9 \pm 0.05, \quad b = 9.6 \pm 0.1$$

Summaries and conclusions

■ Simulations

VTX GEOM	TDR TESLA	TDR TESLA $R_{L0} = 18\text{mm}$	CMOS without side band	CMOS with side band
a	3.6 ± 0.05	3.9 ± 0.05	3.6 ± 0.05	3.6 ± 0.05
b	8.5 ± 0.1	9.6 ± 0.1	8.4 ± 0.1	8.8 ± 0.1

- Amount of matter coming from 2 mm electronic side band and overlapping of several ladders:
 - Modest loss in resolution : b parameter grows by few per cent
 - Two reasons :
 - Beampipe material governs b
 - The parameter b grows essentially like square root of thickness material
- Increasing the radius of the inner layer
 - b parameter is lineary dependent of this radius

[Next steps:

- Simulation still needs to be refined
 - More realistic mechanical support
 - Cabling
 - Light cooling system (if required)
 - Optimisation of the VTX geometry for physics
 - Number of layers ?
 - Conical part in forward region ?

[BACK UP]



Summaries and conclusions /2

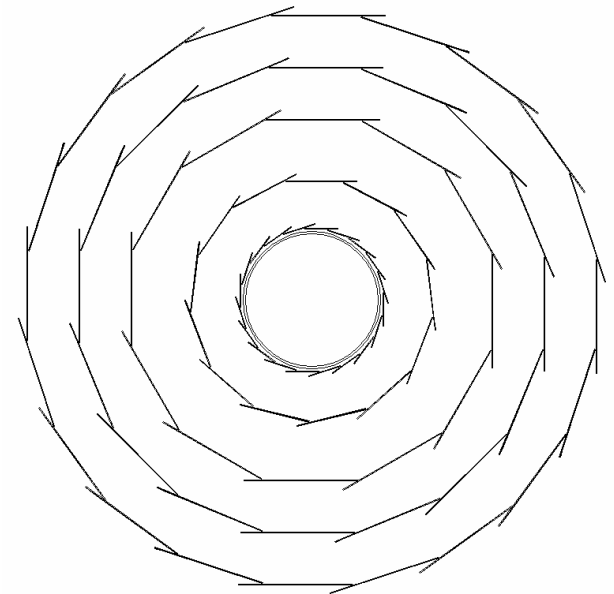
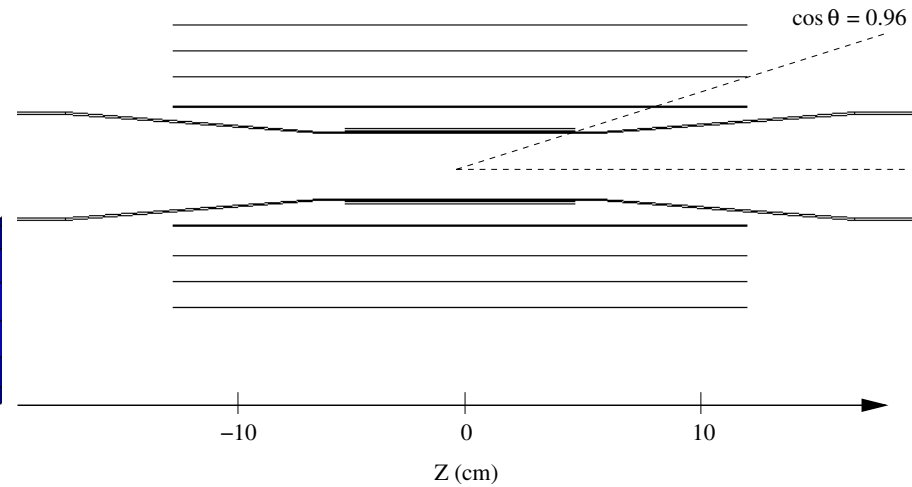
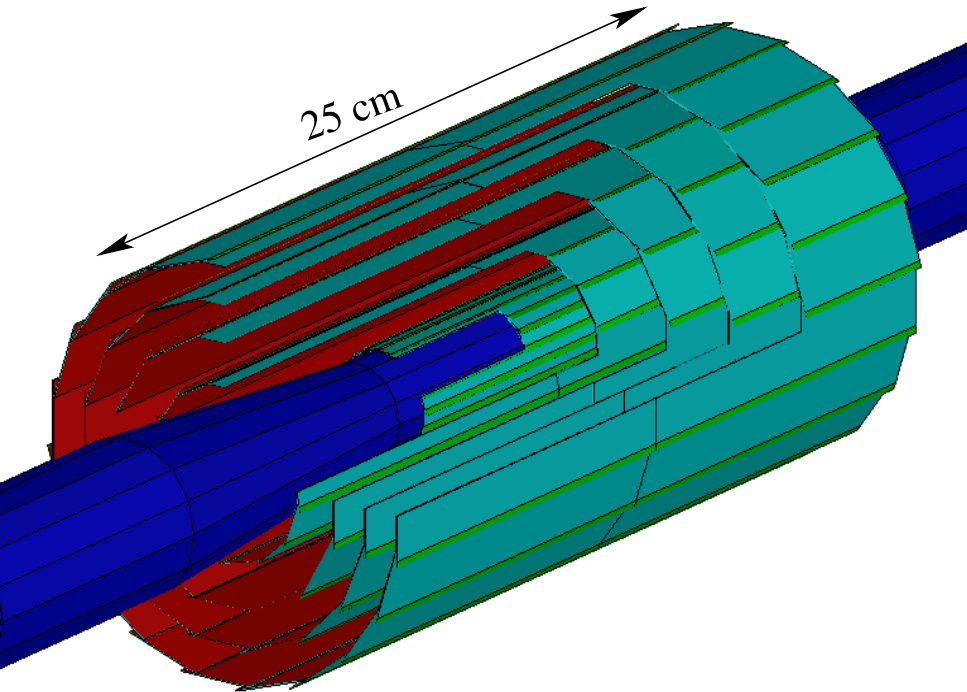
■ Worldwide R&D effort

- Sensor thickness and mechanical support tests
 - Looks to be possible to thin sensor at 50 μm (maybe twice less ?)
 - Very light mechanical support prototypes under test looks very satisfactory
 - but maybe more conservative than expected
- Light cooling system
 - If sensors have low power dissipation and can work around 0° C

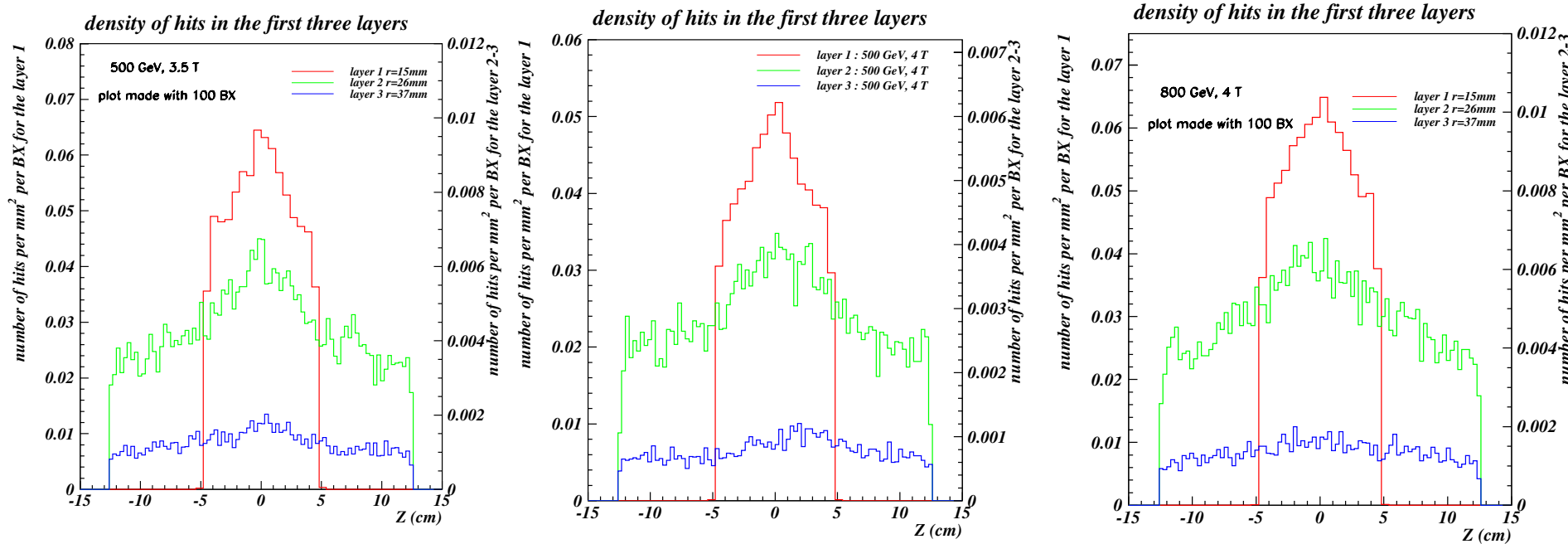
■ Still lot of work to do

- realistic but still a base line
 - pixel conical part ?
 - more realistic mechanical support
 - cabling
 - impact and optimisation of the VTX geometry for physic

CMOS Vertex Detector implemented in BRAHMS



The Beamstrahlung pairs occupancy



Constraints from beamstrahlung background

Base line of the the detector concept TESLA TDR

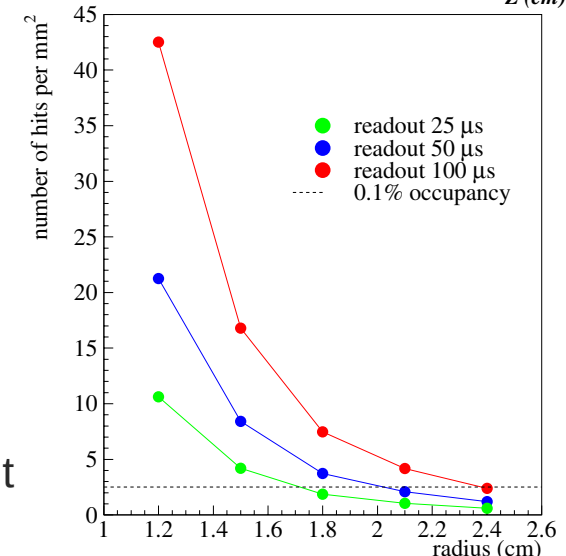
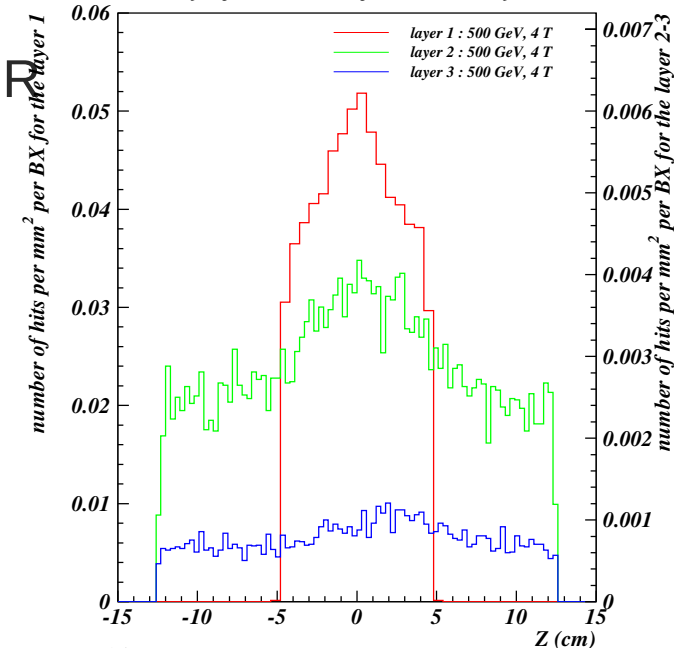
- Radius of the inner layer : 15 mm
- readout speed 50 μs

Question : Is this consistant with beamstrahlung ?

Beamstrahlung pairs

- M.C : 5 hits/ mm^2/BX at 90° in layer L0
 - Cluster multi. (x 5- 10)
 - Safety factor (X 3)
- ⇒ Occupancy 5-10 %
- dictates the readout speed
 - TESLA TDR : 50 μs for the first layer at 1.5 cm
- What if BG much superior to M.C. prediction ?
 - increase the radius of the first layer
 - Not a good solution because parameter b linearly dependent of R_{L0}
 - parameter a increase too
 - Increase the readout speed : technhology dependent
 - Sensor able to work at high frequency
 - Smaller sensor → more material in field bumps but

density of hits in the first three layers



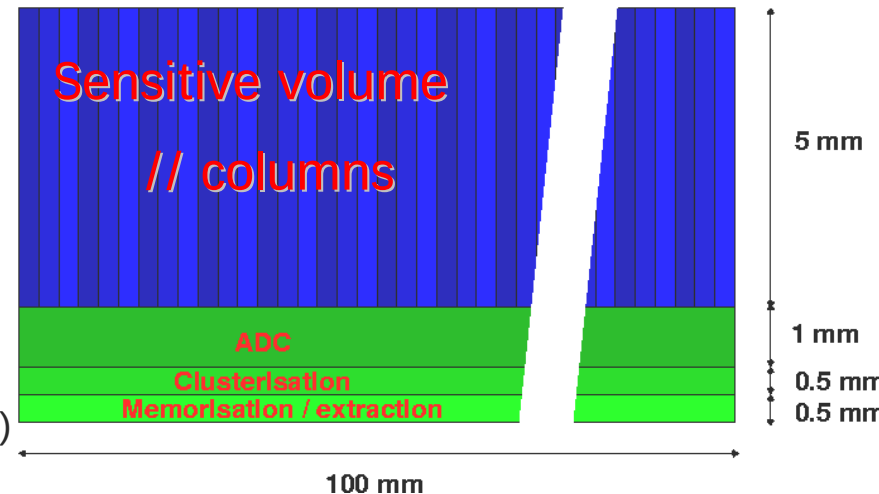
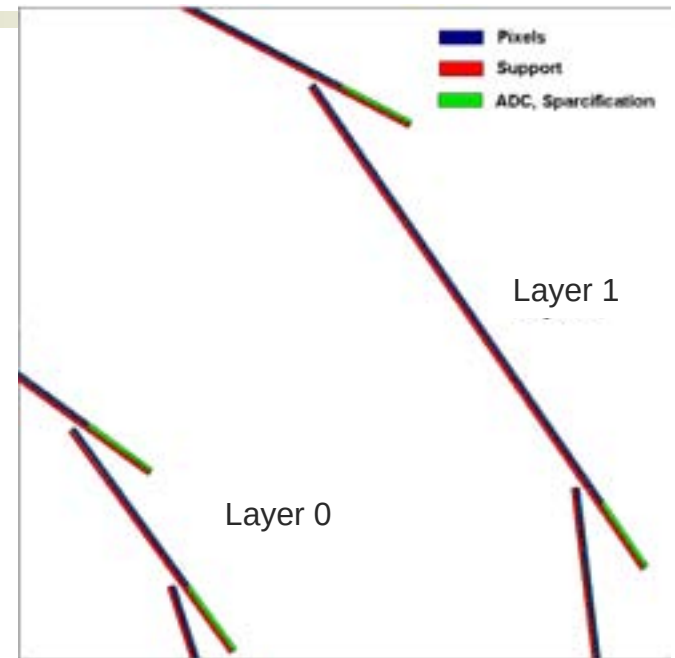
The matter inside the CMOS Vertex Detector

- How to have fast readout ?
 - small chip $\Rightarrow$ more ladders than TDR geom.

- CMOS need electronic side band for digital conversion, sparsification and signal extraction
 - technology limitation
 - amplification and CDS in pixel only
 - small size of the pixel
 - These characteristics increase the amount of matter inside the fiducial volume
 - but there is less matter at small polar angle

- The CMOS sensor could work at $< 0^\circ \text{ C}$?
 - the CMOS could work at ambient temperature
 - thanks to the OPTO fabrication process
 - radiation will increase the dark current
 - work around 0° C to keep high S/N ratio
 - Assume no cryostat needed

- The CMOS VTX implemented in BRAHMS and the impact parameter resolution calculated for different configurations
 - The sensor thickness is $50 \mu\text{m}$ supported by carbon fibre structure of $50 \mu\text{m}$ thick (LBNL tests) $\sim 0.08 \% X_0$ (optimistic ?)



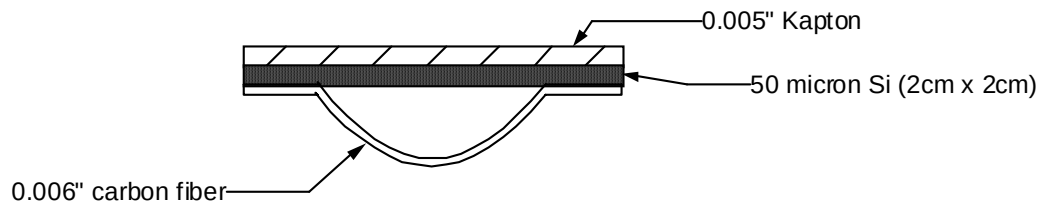
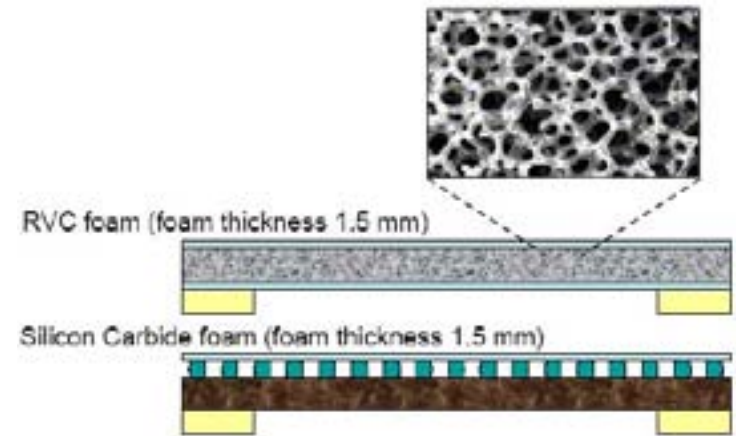
What are our components ? /2

Mechanical support:

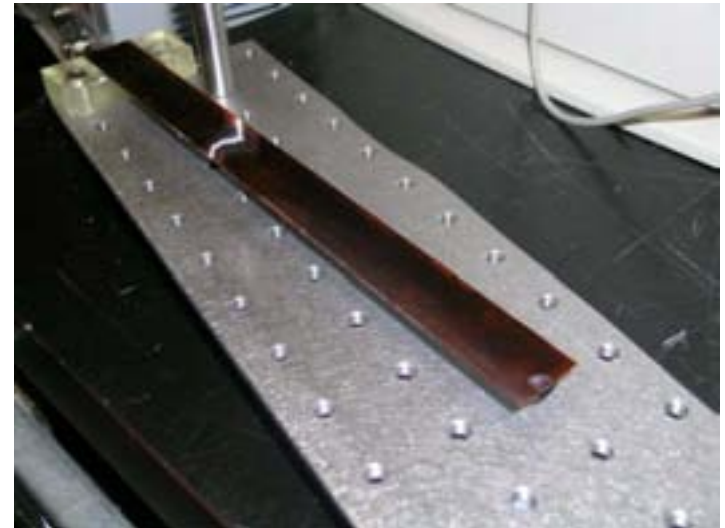
LCFI studies semi-supported sensor

RVC foam : 3.1mm = 0.05% X_0

Silicon Carbide foam : 540 μm = 0.05% X_0



LBNL prototype for STAR upgrade
carbon fiber and kapton ($\sim 0.03\%$ X_0)



A concept of a vertex detector for the ILC relying on CMOS-sensors

Damien Grandjean Marc Winter

- Vertex Detector reminder
- How to decrease material budget ?
- Constraints from beamstrahlung background
- Study example : the CMOS Vertex Detector concept
 - The matter inside the CMOS Vertex Detector
 - Simulation Results
- Summaries and conclusions